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Report No.: SHEM161100716401
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1 Cover Page

TEST REPORT

Application No.:	SHEM1611007164IT
Applicant:	Zhejiang Dahua Vision Technology Co., Ltd.
Equipment under Test (EUT)	
NOTE: The following sample(s) was/were submitted and identified by the client as.	
Product Name:	Indoor Station
Model No.(EUT):	DHI-VTH1550CH
Add Model No.:	DH-VTH1550CH, VTH1550CH, DH-VTH1510CH, DHI-VTH1510CH, VTH1510CH, OEM-VTH1510CH
Standards:	EN 55032:2015, EN 55024:2010+A1:2015
	EN 61000-3-2:2014, EN 61000-3-3:2013
	EN 50130-4:2011+A1:2014
Date of Receipt:	August 24, 2015
Date of Test:	August 28, 2015 to September 07, 2015
Date of Issue:	November 14, 2016
Test Result:	Pass*

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EC Declaration of Conformity and compliance with all relevant EU Directives.



Parlam Zhan
E&E Section Manager
SGS-CSTC (Shanghai) Co., Ltd.

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government. All test results in this report can be traceable to National or International Standards.

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2 Test Summary

ELECTROMAGNETIC INTERFERENCE (EMI)			
Test	Test Requirement	Test Method	Result
Conducted Emission (150kHz to 30MHz)	EN 55032:2015	EN 55032:2015	PASS
Radiated Emission, (30MHz to 1GHz)	EN 55032:2015	EN 55032:2015	PASS*
Harmonic Emission on AC, (100 Hz to 2 kHz)	EN 61000-3-2:2014	EN 61000-3-2:2014	N/A**
Flicker Emission on AC	EN 61000-3-3:2013	EN 61000-3-3:2013	PASS
Electromagnetic Susceptibility(EMS)			
Test	Test Requirement	Test Method	Result
Electrostatic discharge	EN 55024:2010+A1:2015 & EN 50130-4:2011+A1:2014	EN 61000-4-2:2009	PASS
Radiated electromagnetic fields	EN 55024:2010+A1:2015 & EN 50130-4:2011+A1:2014	EN 61000-4-3: 2006+A1:2008+A2:2010	PASS
Fast transient bursts	EN 55024:2010+A1:2015 & EN 50130-4:2011+A1:2014	EN 61000-4-4:2014	PASS
Slow high energy voltage surge	EN 55024:2010+A1:2015 & EN 50130-4:2011+A1:2014	EN 61000-4-5:2014	PASS
Conducted disturbances induced by electromagnetic fields	EN 55024:2010+A1:2015 & EN 50130-4:2011+A1:2014	EN 61000-4-6:2014	PASS
Mains supply voltage dips and short interruptions	EN 55024:2010+A1:2015 & EN 50130-4:2011+A1:2014	EN 61000-4-11:2004	PASS
Mains supply voltage variations	EN 50130-4:2011+A1:2014	EN 50130-4:2011	PASS
Remark:			
EUT In this whole report EUT means Equipment Under Test.			
Note1:* If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz.			
Note2: Please refer to Section 7.3 of this report for details.			
Note3: There are 3 models mentioned in this report, and they are the similar in electrical and electronic characters. Only the model DHI-VTH1550CH was tested since their differences were the model number, trade name and appearance deviation.			
Note4: The report is copied from SHEM160400173101 to add models DH-VTH1510CH, DHI-VTH1510CH, VTH1510CH, OEM-VTH1510CH which are the same as the original tested model DHI-VTH1550CH in electrical and electronic characters. So the new models in this report are deemed to fulfill the EMC requirements without testing.			
Note5: The report is copied from SHEM160400173101 to update standard, add models and company address.			

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4 General Information

4.1 Client Information

Applicant: Zhejiang Dahua Vision Technology Co., Ltd.
 Address of Applicant: No.1199, Bin'an Road, Binjiang District, Hangzhou, P.R. China
 Manufacturer: Zhejiang Dahua Vision Technology Co., Ltd.
 Address of Manufacturer: No.1199, Bin'an Road, Binjiang District, Hangzhou, P.R. China
 Factory: Zhejiang Dahua Vision Technology Co., Ltd.
 Address of Factory: No.1199, Bin'an Road, Binjiang District, Hangzhou, P.R. China

4.2 Details of E.U.T.

Power Supply: For EUT: DC 12V
 For Adaptor:
 Model: ADS-12B-12
 Input: AC 100V-240V
 Output: DC 12V, 1A
 Test Voltage: AC 230V, 50Hz
 Cable Type: 150cm Length (2 wires) for DC cable (Supply by Client)

4.3 E.U.T Operation Mode

Functions/Modes: Running mode
 Running mode: Keep EUT running continual.

4.4 E.U.T Operation Environment

Temperature Range: 20-25°C
 Humidity Range: 30-60% RH
 Atmospheric Pressure Range: 100-105kPa

4.5 Description of Support Units

The EUT has been tested with associated equipment below.

Description	Manufacturer	Model No.
Adapter	HONOR	ADS-12B-12
Laptop	Lenovo	R400

4.6 Deviation from Standards

All Immunity tests to EN 55024 & EN 50130-4 were performed in accordance with EN 61000-4-x and not IEC 61000-4-x. (x=2,3,4,5,6,11).

4.7 Abnormalities from Standard Conditions

None.

4.8 Modification/Retest Record

None.

4.9 Monitoring of EUT for All Immunity Test

Audio: None.

Visual: Working status of the EUT.

4.10 Test Location

Radiated Emission(30MHz to 1GHz) tests were performed at:

Inventec Pudong EMC Center

No. 699, Puxing Rd., Shanghai, China

TEL: +86-21-6429-8888 ext: 65429

other tests were performed at:

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. E&E Lab

588 West Jindu Road, Xinqiao, Songjiang, 201612 Shanghai, China.

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4.11 Test Facility

- **CNAS (No. CNAS L0599)**

CNAS has accredited SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing. Date of expiry: 2017-07-14.

- **FCC – Registration No.: 402683**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered and fully described in a report filed with the Federal Communications Commission (FCC). The acceptance letter from the FCC is maintained in our files. Registration No.: 402683, Expiry Date: 2017-09-16.

- **Industry Canada (IC) – IC Assigned Code: 8617A**

The 3m Semi-anechoic chamber of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 8617A-1. Expiry Date: 2017-06-18.

- **VCCI (Member No.: 3061)**

The 3m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-3868,C-4336,T-2221,G-830 respectively. Date of Expiry: 2017-11-16.

4.12 Measurement Uncertainty

According to CISPR 16-4-2.

Test Item	Frequency Range	Measurement Uncertainty	U _{cispr}
Conducted Emission at mains port using AMN	9kHz-150kHz	3.2 dB	3.8 dB
Conducted Emission at mains port using AMN	150kHz-30MHz	3.0 dB	3.4 dB
Conducted Emission at mains port using VP	9kHz-30MHz	3.9 dB	2.9 dB
Conducted Emission at telecommunication port using AAN	150kHz-30MHz	4.5 dB	5.0 dB
Radiated Emission	30MHz-1000MHz	4.4 dB	6.3 dB
Radiated Emission	1GHz-18GHz	4.6 dB	5.2 dB (1GHz-6GHz)
			5.5 dB (6GHz-18GHz)
Disturbance Power	30MHz-300MHz	3.5 dB	4.5 dB
Remark: AMN – Artificial Mains Network VP – Voltage Probe ANN – Asymmetric Artificial Network			

Note: The measurement uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

5 Equipment list

Conducted Emission

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due date
1	EMI test receiver	Rohde & Schwarz	ESCS30	100086	2015-01-22	2016-01-21
2	Line impedance stabilization network	SCHWARZBECK	NSLK8127	8127-490	2015-01-22	2016-01-21
3	Line impedance stabilization network	EMCO	3816/2	00034161	2015-01-22	2016-01-21

Radiated Emission

Instrument	Manufacturer	Type No.	Serial No.	Cal. Date	Cal. Interval	Cal. Body
Bilog-antenna	TESEQ	CBL-6112D	28034	1/12/2015	3Y	ETC
Bilog-antenna	TESEQ	CBL-6112D	28035	9/04/2013	3Y	ETC
Preamplifier	Agilent	8447D	2944A11032	1/9/2015	1Y	Inventec
Preamplifier	Agilent	8447D	2944A11035	1/9/2015	1Y	Inventec
Test Receiver	R&S	ESCI	100523	1/9/2015	1Y	SIMT
Test Receiver	R&S	ESCI	100526	1/9/2015	1Y	SIMT

Flicker

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due date
1	Single phase harmonics & flicker analyzer	EM test	DPA500	V0507100125	2015-01-22	2016-01-21
2	AC SOURCE 6KVA	EM test	ACS500	V0507100126	2015-01-22	2016-01-21

Electrostatic Discharge Test

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal.Due date
1	Electrostatic Discharge Simulator	TESEQ	NSG 437	468	2015-08-25	2016-08-24

Fast transient bursts Test

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal.Due date
1	EMS test machine	EMC Partner	TRA3000 F-S-D-V	1229	2015-01-04	2016-01-03
2	Data coupling network 4 line	EM test	CNV 504	40200020 01	2015-08-06	2016-08-05

Slow high energy voltage surge Test

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal.Due date
1	EMS test machine	EMC Partner	TRA3000 F-S-D-V	1229	2015-01-04	2016-01-03
2	Data coupling network 4 line	EM test	CNV 504	40200020 01	2015-08-06	2016-08-05

Mains supply voltage dips and short interruptions / Mains supply voltage variations Test

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal.Due date
1	EMS test machine	EMC Partner	TRA3000 F-S-D-V	1229	2015-01-04	2016-01-03

Radiated Immunity

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal.Due date
1	Single Generator	Rohde & Schwarz	SMJ100A	101394	2015-01-22	2016-01-21
2	Calibrated Stacked Lagarithmic-Periodic Test-Antenna	SCHWARIBFC K	STLP 9128D	9128 D 055	/	/
3	Stacked DoubleLog-Per. Antenna	SCHWARIBFC K	STLP 9149	9149-187	/	/
4	Power Amplifiers	MILMEGA	80RF1000 -250	1053058	/	/
5	Power Amplifiers	MILMEGA	AS0840-5 5-55	1053059	/	/
6	Power Meter	Rohde & Schwarz	NRP	101641	2015-01-22	2016-01-21
7	Electromagnetic Field Probe	ETS-Lindgren	HI-6113	00011459 1	2014-09-10	2015-09-09
8	Power sensor	Rohde & Schwarz	NRP-Z91	100647	2015-01-22	2016-01-21
9	Power sensor	Rohde & Schwarz	NRP-Z22	101096	2015-08-06	2016-08-05
10	ElectroMagnetic Field Probe	ETS-Lindgren	HI-6113	00114591	2015-08-12	2016-08-11

Conducted disturbances induced by electromagnetic fields

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal.Due date
1	signal generator	Rohde & Schwarz	SMY01	101394	2015-01-22	2016-01-21
2	PAMP Conducted RF test system	HAEFFLY	PAMP250	151708	2015-01-22	2016-01-21
3	CDN impedance and K-factor	LUTHI	L-801 M1	2116	/	/
4	CDN impedance and K-factor	LUTHI	L-801 M2/M3	2117	2015-01-22	2016-01-21
5	Coupling Clamp	LUTHI	EM 101	35724	2015-01-22	2016-01-21

General Equipment

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Cal.Due date
1	Digital pressure meter	YONGZHI	DYM3-01	101012	2015-04-13	2016-04-12
2	Temperature & humidity recorder	ShangHai weather meter work	ZJ 1-2B	84320600 803136, F3040201 53,20101 201FS10 0A6K,201 106117	2015-08-03	2016-08-02
3	Digital Multimeter	FLUKE	17B	19720439	2015-01-22	2016-01-21
4	Autoformer regulator	Guangzhou bao de	TDGC2-5K VA-	/	/	/
5	CLAMP METER	FLUKE	316	250303097 1	2015-01-22	2016-01-21

6 Electromagnetic Interference Test Results

6.1 Conducted Emissions on Mains Terminals, 150 kHz to 30 MHz

Detector: Peak for pre-scan (9 kHz Resolution Bandwidth from 150 kHz to 30 MHz)

Class / Limit: Table 2-Class B

Frequency range MHz	Class B Limits dB (μV)	
	Quasi-peak	Average
0.15 to 0.50	66 to 56	56 to 46
0.50 to 5	56	46
5 to 30	60	50

Note1: The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50MHz.
 Note2: The lower limit is applicable at the transition frequency.

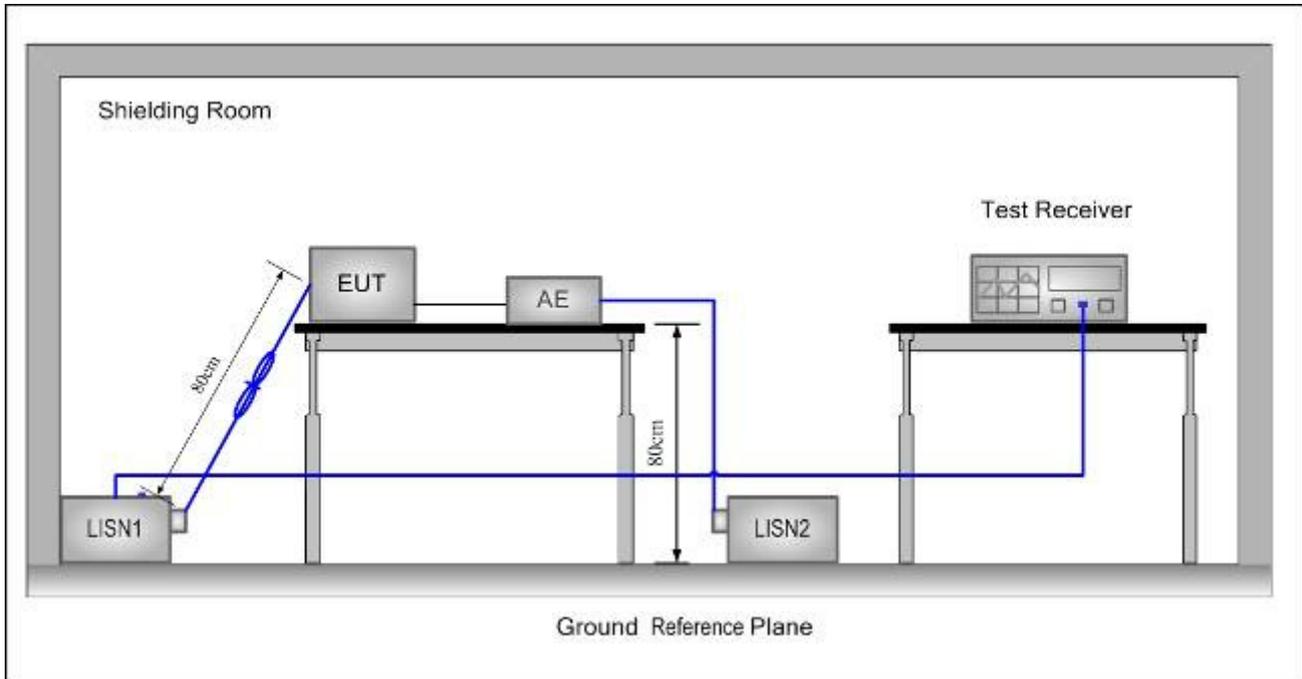
6.1.1 E.U.T. Operation

Test mode: Running mode

Pre-scan was performed with peak detected on all ports, Quasi-peak & average measurements were performed at the frequencies at which maximum peak emission level were detected.

Please see the attached Quasi-peak and Average test results.

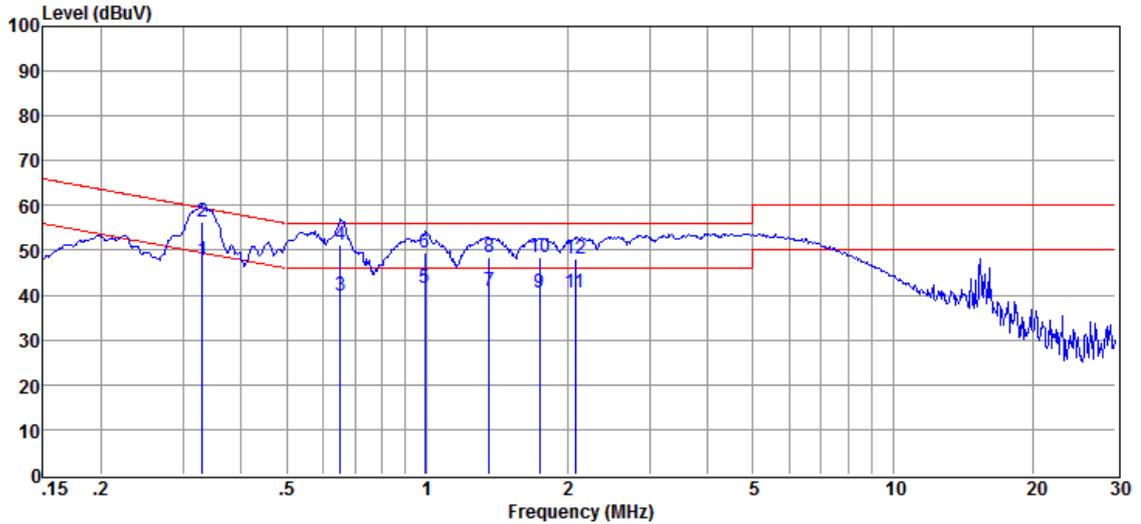
6.1.2 Test Setup and Procedure



1. The mains terminal disturbance voltage was measured with the EUT in a shielded room.
2. The EUT was connected to AC power source through a LISN 1 (Line Impedance Stabilization Network) which provides a $50\Omega/50\mu\text{H} + 5\Omega$ linear impedance. The power cables of all other units of the EUT was connected to a second LISN, which was bonded to the ground reference plane in the same way as the LISN for the unit being measured. A multiple socket outlet strip was used to connect multiple power cables to a single LISN provided the rating of the LISN was not exceeded
3. The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.
4. The test was performed with a vertical ground reference plane. The rear of the EUT shall be 0.4 m from the vertical ground reference plane. The vertical ground reference plane was bonded to the horizontal ground reference plane. The LISN was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane for LISN mounted on top of the ground reference plane. This distance was between the closest points of the LISN and the EUT. The mains lead of EUT excess 0.8m was folded back and forth parallel to the lead so as to form a horizontal bundle with a length between 0.3m and 0.4m. All other units of the EUT and associated equipment was at least 0,8 m from the LISN.

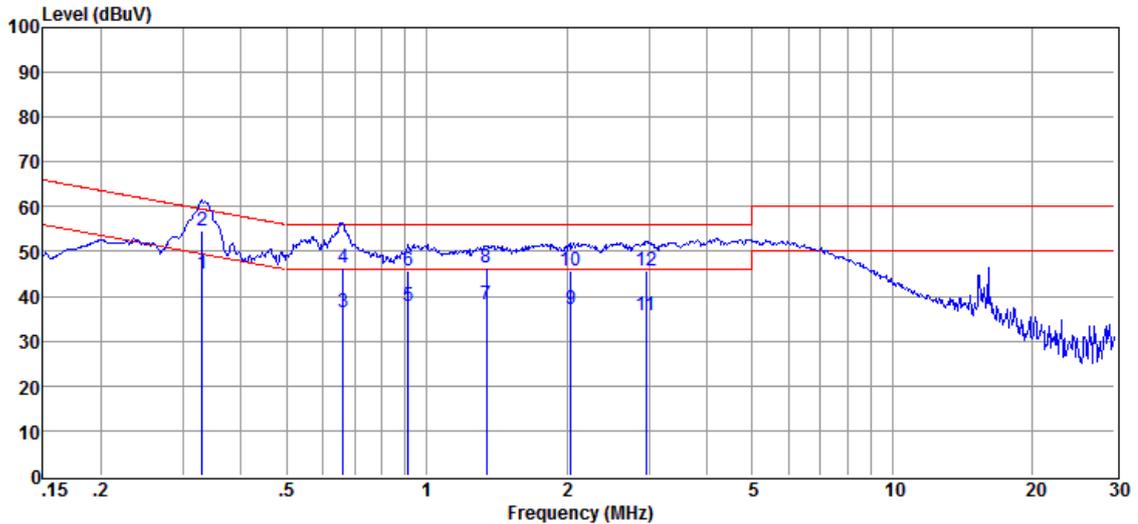
6.1.3 Measurement Data

Live Line:



Item	Freq.	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Detector
(Mark)	(MHz)	(dB μ V)	(dB)	(dB)	(dB μ V)	(dB μ V)	(dB)	
1	0.330	37.82	0.25	9.86	47.93	49.44	-1.51	Average
2	0.330	46.41	0.25	9.86	56.52	59.44	-2.92	QP
3	0.651	29.76	0.23	9.86	39.85	46.00	-6.15	Average
4	0.651	41.01	0.23	9.86	51.10	56.00	-4.90	QP
5	0.989	31.52	0.17	9.87	41.56	46.00	-4.44	Average
6	0.989	39.55	0.17	9.87	49.59	56.00	-6.41	QP
7	1.359	30.74	0.25	9.87	40.86	46.00	-5.14	Average
8	1.359	38.45	0.25	9.87	48.57	56.00	-7.43	QP
9	1.744	30.50	0.32	9.87	40.69	46.00	-5.31	Average
10	1.744	38.33	0.32	9.87	48.52	56.00	-7.48	QP
11	2.077	30.23	0.36	9.87	40.46	46.00	-5.54	Average
12	2.077	37.91	0.36	9.87	48.14	56.00	-7.86	QP

Neutral Line:



Item	Freq.	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Detector
(Mark)	(MHz)	(dBμV)	(dB)	(dB)	(dBμV)	(dBμV)	(dB)	
1	0.330	34.99	0.30	9.86	45.15	49.44	-4.29	Average
2	0.330	44.45	0.30	9.86	54.61	59.44	-4.83	QP
3	0.661	26.21	0.21	9.86	36.28	46.00	-9.72	Average
4	0.661	36.30	0.21	9.86	46.37	56.00	-9.63	QP
5	0.914	27.58	0.22	9.87	37.67	46.00	-8.33	Average
6	0.914	35.62	0.22	9.87	45.71	56.00	-10.29	QP
7	1.345	27.60	0.56	9.87	38.03	46.00	-7.97	Average
8	1.345	35.86	0.56	9.87	46.29	56.00	-9.71	QP
9	2.044	26.43	0.98	9.87	37.28	46.00	-8.72	Average
10	2.044	34.76	0.98	9.87	45.61	56.00	-10.39	QP
11	2.962	24.99	0.75	9.87	35.61	46.00	-10.39	Average
12	2.962	35.03	0.75	9.87	45.65	56.00	-10.35	QP

Level = Read Level + LISN/ISN Factor + Cable Loss

6.2 Radiated Emissions, 30MHz to 1GHz

Detector: Peak for pre-scan (120 kHz resolution bandwidth)

Class / Limit: Table 6-Class B

For 10m

Frequency range	Quasi-peak limits(Class B)
MHz	dB (μV/m)
30 to 230	30
230 to 1000	37
At transitional frequencies the lower limit applies.	

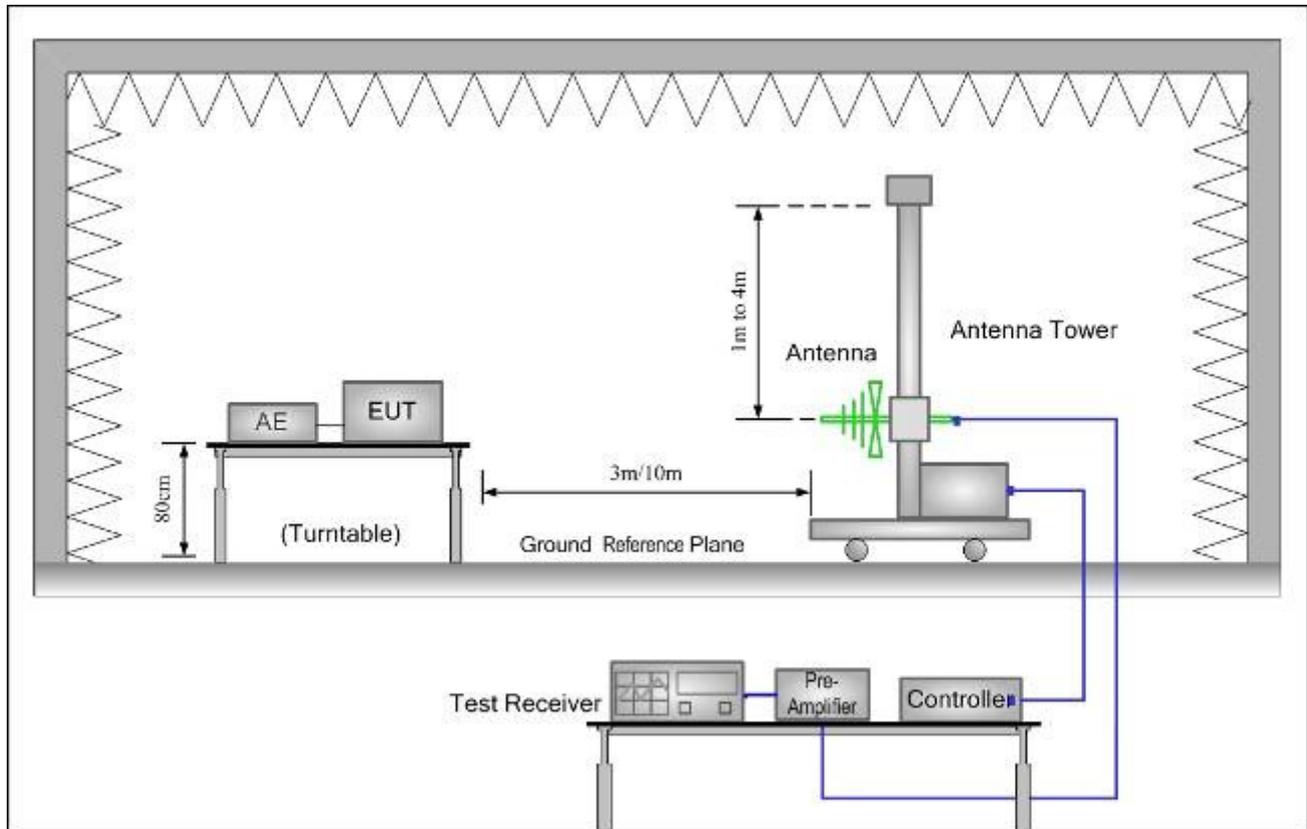
6.2.1 E.U.T. Operation

Test mode: Running mode

Pre-scan was performed with peak detected on all ports, Quasi-peak measurements was performed at the frequencies at which maximum peak emission level were detected.

Please see the attached Quasi-peak test results.

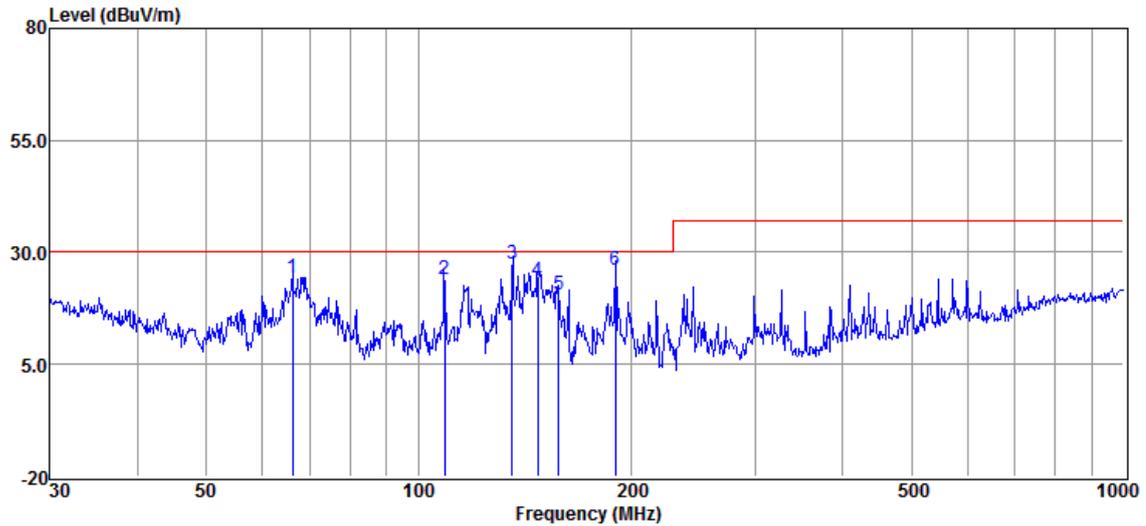
6.2.2 Test Setup and Procedure



1. The radiated emissions test was conducted in a semi-anechoic chamber.
2. The EUT was connected to AC power source through a mains power outlet which was bonded to the ground reference plane; The mains cables shall drape to the ground reference plane.
3. The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.
4. Before final measurements of radiated emissions, a pre-scan was performed in the spectrum mode with the peak detector to find out the maximum emission spectrum signature data plots of the EUT.
5. The frequencies of maximum emission were determined in the final radiated emissions measurement, the physical arrangement of the test system and associated cabling was varied in order to determine the effect on the EUT's emissions in amplitude, direction and frequency. At each frequency, the EUT was rotated 360°, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum disturbance. Measurements were performed for both horizontal and vertical antenna polarization.

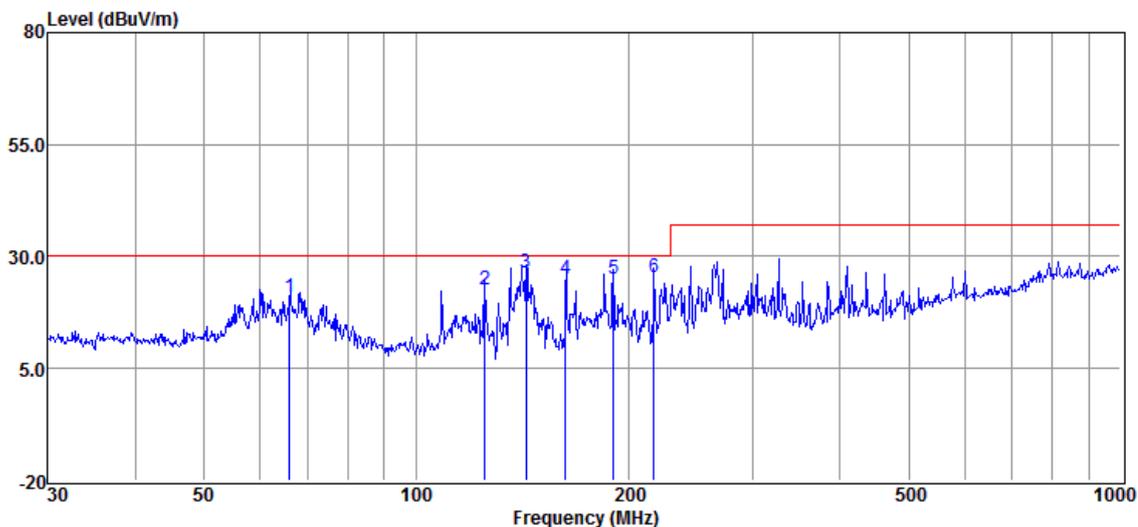
6.2.3 Measurement Data

Vertical:



Item	Freq.	Read Level	Antenna Factor	Preamp Factor	Cable Loss	Result Level	Limit Line	Over Limit	Detector
(Mark)	(MHz)	(dB μ V)	(dB/m)	(dB)	(dB)	(dB μ V/m)	(dB μ V/m)	(dB)	
1	66.20	35.50	12.44	24.60	0.83	24.17	30.00	-5.83	QP
2	108.76	36.79	10.69	24.60	1.13	24.01	30.00	-5.99	QP
3	135.82	38.39	12.13	24.54	1.30	27.28	30.00	-2.72	QP
4	147.62	34.26	12.68	24.51	1.36	23.79	30.00	-6.21	QP
5	158.23	31.49	12.22	24.50	1.41	20.62	30.00	-9.38	QP
6	190.20	37.97	11.09	24.50	1.54	26.10	30.00	-3.90	QP

Horizontal:



Item	Freq.	Read Level	Antenna Factor	Preamp Factor	Cable Loss	Result Level	Limit Line	Over Limit	Detector
(Mark)	(MHz)	(dBμV)	(dB/m)	(dB)	(dB)	(dBμV/m)	(dBμV/m)	(dB)	
1	66.13	32.18	12.45	24.60	0.83	20.86	30.00	-9.14	QP
2	125.07	34.07	11.85	24.57	1.24	22.59	30.00	-7.41	QP
3	143.27	37.00	12.46	24.52	1.34	26.28	30.00	-3.72	QP
4	162.96	35.82	12.13	24.50	1.43	24.88	30.00	-5.12	QP
5	190.61	37.01	11.08	24.50	1.55	25.14	30.00	-4.86	QP
6	217.58	38.17	10.12	24.50	1.72	25.51	30.00	-4.49	QP

$$\text{Level} = \text{Read Level} + \text{Antenna Factor} + \text{Cable Loss} - \text{Preamp Factor}$$

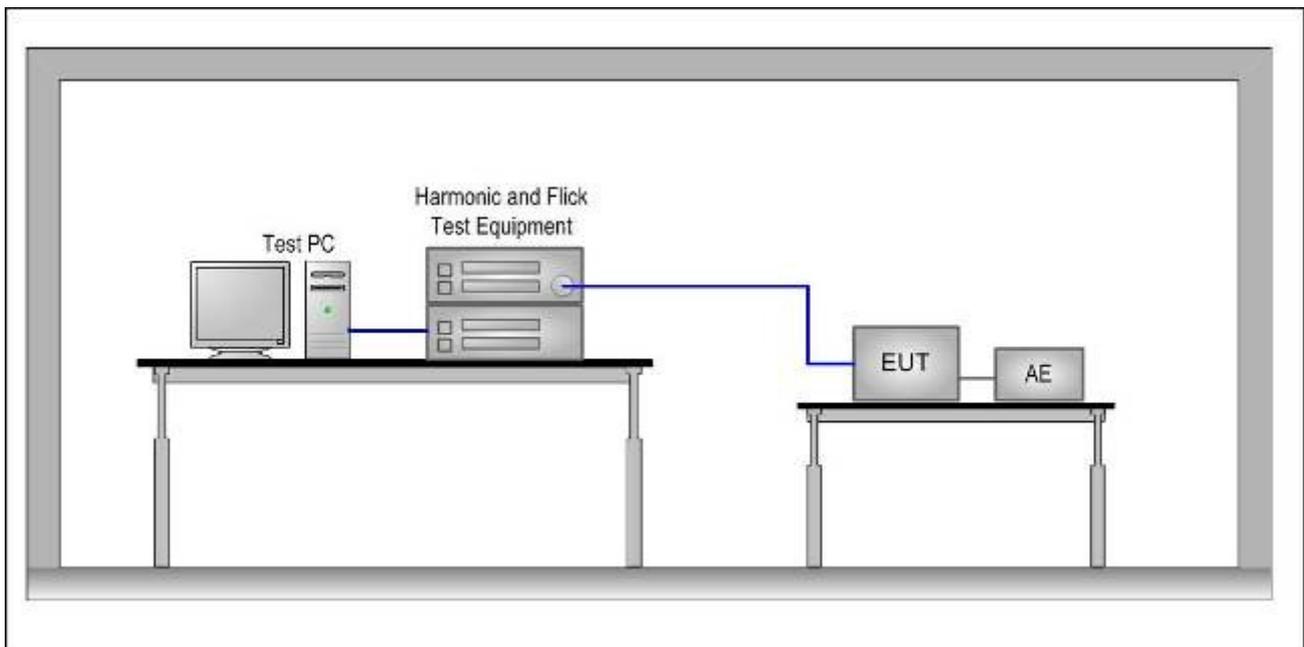
6.3 Harmonics Test Result

Measurement Time: 2.5mins
Class / Severity: Class A

6.3.1 E.U.T. Operation

Test mode: N/A

6.3.2 Test Setup and Procedure



1. The EUT was tested with the equipment configured to its rated current.
2. The measurements were carried out under steady conditions. When a piece of EUT is brought into operation or is taken out of operation, manually or automatically, harmonic currents and power are not taken into account at first 10s following the switching event. EUT shall not be in standby mode for more than 10% of any observation period.
3. Harmonics of the fundamental current were measured using a digital power meter with an analogue output and frequency analyser which was integrated in the harmonic & flicker test system.
4. For each harmonic order, measure the 1,5 s smoothed r.m.s. harmonic current in each DFT time window and calculate the arithmetic average of the measured values from the DFT time windows, over the entire observation period. Each harmonic order, all 1.5 s smoothed r.m.s. harmonic current values and the average values for the individual harmonic currents, taken over the entire test observation period shall be less than or equal to the applicable limits.

6.3.3 Measurement Data

There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2.

6.4 Flicker Test Result

Measurement Time: 120 mins
Class / Severity: Clause 5 of EN 61000-3-3

6.4.1 E.U.T. Operation

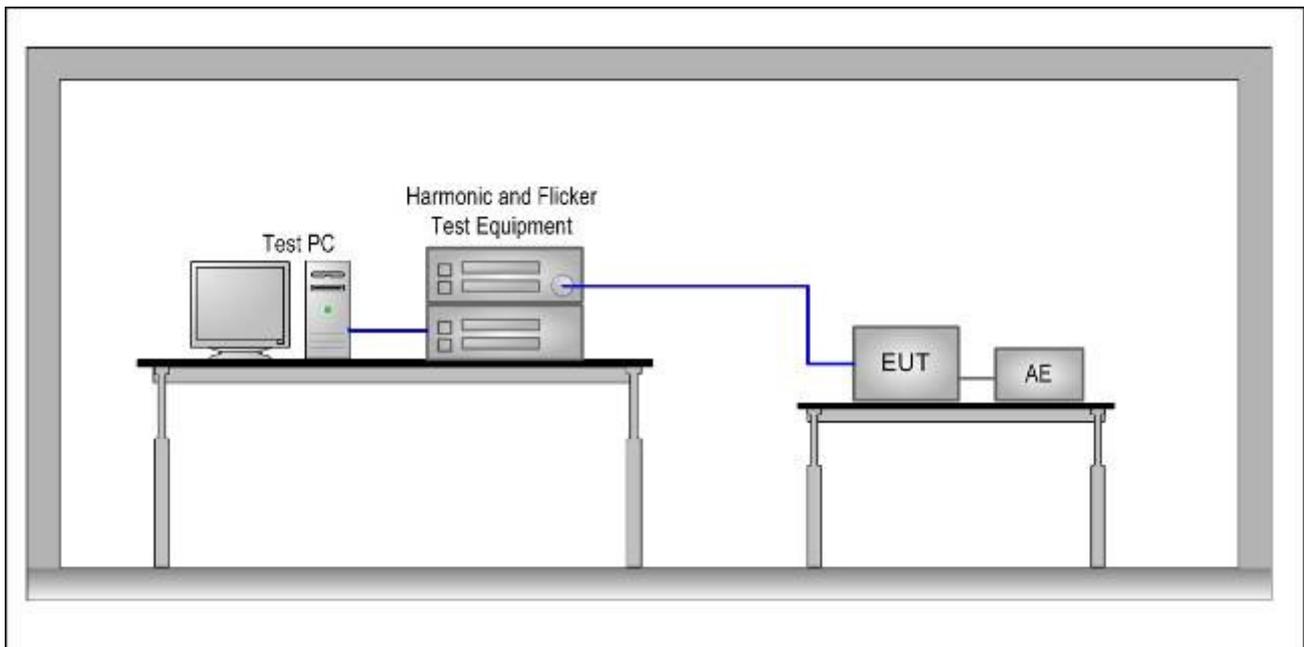
Test mode: Running mode

Note: "Pst and Plt requirements shall not be applied to voltage changes caused by manual switching.

The limits shall not be applied to voltage changes associated with emergency switching or emergency interruptions."

Please also refer to Annex A (Application of limits and type test conditions) for details in EN 61000-3-3.

6.4.2 Test Setup and Procedure



1. The test supply voltage (open-circuit voltage) was the rated voltage of the EUT. The Test voltage: was maintained within $\pm 2\%$ of the nominal value. The frequency was 50 Hz $\pm 0.5\%$.
2. The voltage fluctuations and flicker were measured at the supply terminals of the EUT.
3. The observation period, T_p , for the assessment of flicker values by flicker measurement, flicker simulation, or analytical method was:
 - for Pst, $T_p = 10$ min;
 - for Plt, $T_p = 2$ h.

The observation period included that part of the whole operation cycle in which the EUT produces the most unfavorable sequence of voltage changes.

6.4.3 Measurement Data

Maximum Flicker results

	EUT values	Limit	Result
Pst	0.028	1.00	PASS
Plt	0.028	0.65	PASS
dc [%]	0.000	3.30	PASS
dmax [%]	0.064	4.00	PASS
Tmax [s]	0.000	0.50	PASS

7 Electromagnetic Susceptibility Test Results

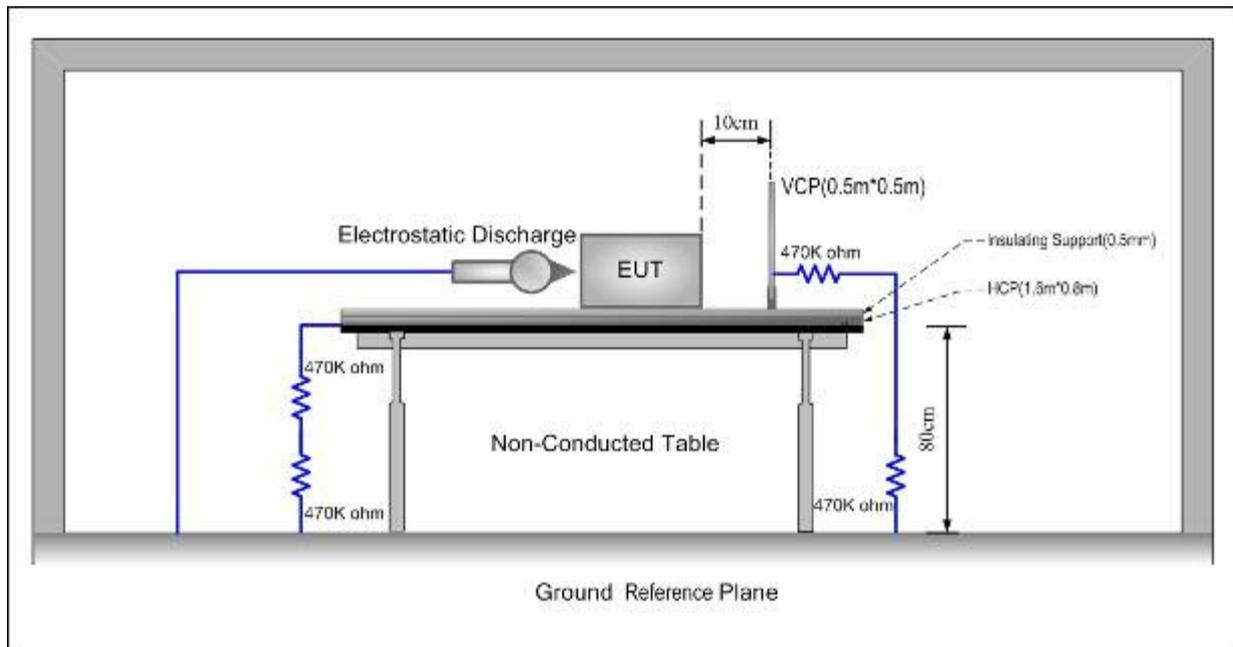
7.1 Performance Criteria Description in Clause 7 of EN 55024

<p>Criterion A:</p>	<p>The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.</p>
<p>Criterion B:</p>	<p>After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.</p> <p>During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.</p> <p>If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.</p>
<p>Criterion C:</p>	<p>Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.</p> <p>Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.</p>

7.2 Electrostatic discharge

Discharge Voltage:	Air Discharge:	± 2 kV, ± 4 kV, ± 8 kV
	Contact Discharge:	± 4.0 kV, ± 6.0 kV
	HCP/VCP:	± 4.0 kV, ± 6.0 kV
Polarity:	Positive & Negative	
Number of Discharge:	Minimum 10 times at each test point for Air Discharge; Minimum 50 times at each test point for Contact or VCP & HCP Discharge.	
Discharge Mode:	Single Discharge	
Discharge Period:	1 second minimum	
Criteria for compliance:	There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. (for EN 50130)	

7.2.1 Test Setup and Procedure



- Contact discharge was applied only to conductive surfaces of the EUT. Air discharge was applied only to non-conducted surfaces of the EUT.
- The EUT was put on a 0.8m high wooden table for table-top equipment or 0.1m high for floor standing equipment standing on the ground reference plane (GRP).
- A horizontal coupling plane(HCP) 1.6m by 0.8m in size was placed on the table, and the EUT with its cables were isolated from the HCP by an insulating support thick than 0.5mm. The VCP 0.5m by 0.5m in size while HCP were constructed from the same material type and thickness as that of the GRP, and connected to the GRP via a 470k Ω resistor at each end. The distance between EUT and any of the other metallic surface excepted the GRP, HCP and VCP was greater than 0.8m.
- During the contact discharges, the tip of the discharge electrode was touch the EUT before the discharge

switch is operated. During the air discharges, the round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT.

5. After each discharge, the ESD generator was removed from the EUT, the generator is then retriggered for a new single discharge. For ungrounded product, a discharge cable with two resistances were used after each discharge to remove remnant electrostatic voltage. A minimum 50 times discharges at each point of each polarity single discharge were applied to HCP and VCP.

7.2.2 Test Results

For EN 55024

Direct Application Test Results

- Observations: Test Point:
1. All insulated enclosure & seams.
 2. All accessible metal parts of the enclosure.

Direct Application		Test Results			
Discharge Level (kV)	Polarity (+/-)	Test Point	Test Mode	Contact Discharge	Air Discharge
8.0	+/-	1	Running mode	N/A	A
4.0	+/-	2		A	N/A

Indirect Application Test Results

- Observations: Test Point:
1. All sides.

Indirect Application		Test Results			
Discharge Level (kV)	Polarity (+/-)	Test Point	Test Mode	Horizontal Coupling	Vertical Coupling
4.0	+/-	1	Running mode	A	A

Results:

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

N/A: Not applicable (floor mounted EUT or not requested by Standard).

For EN 50130

Direct Application Test Results

Observations: Test Point:
 1. All insulated enclosure & seams.
 2. All accessible metal parts of the enclosure.

Direct Application		Test Results			
Discharge Level (kV)	Polarity (+/-)	Test Point	Test Mode	Contact Discharge	Air Discharge
2,4,8	+/-	1	Running mode	N/A	Pass
6	+/-	2		Pass	N/A

Indirect Application Test Results

Observations: Test Point:
 1. All sides.

Indirect Application		Test Results			
Discharge Level (kV)	Polarity (+/-)	Test Point	Test Mode	Horizontal Coupling	Vertical Coupling
6	+/-	1	Running mode	Pass	Pass

Results: Pass

Test phenomenon description for the EUT:

1. The EUT working normal, before the conditioning.
2. Monitor the EUT during the conditioning period to detect no any change in status, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

N/A: Not applicable (not required in the standard or floor mounted the EUT)

7.3 Radiated electromagnetic fields

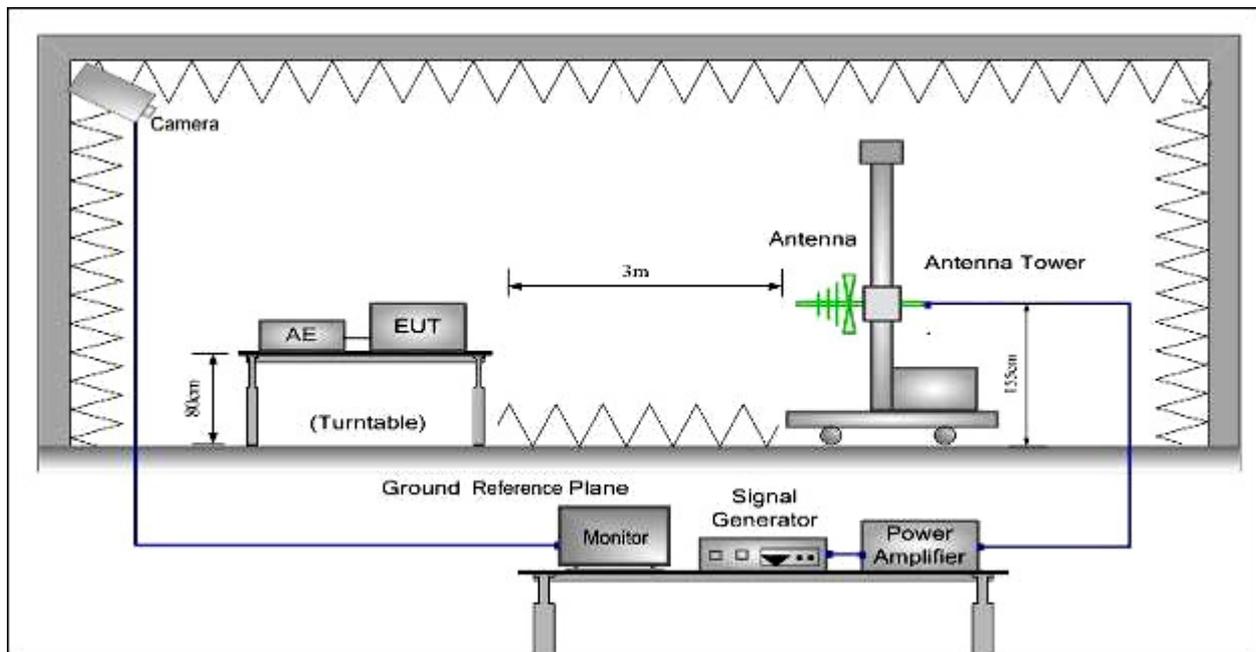
For EN 55024

Frequency Range:	80 MHz to 1 GHz
Antenna Polarization:	Horizontal & Vertical
Test level:	3.0 V/m on enclosure
Modulation:	80%, 1 kHz Amplitude Modulation

For EN 50130

Frequency Range:	80 MHz to 2.7 GHz
Test level:	10 V/m on enclosure
Modulation:	80%, 1 kHz Amplitude Modulation & 0.5s ON 0.5s OFF Pulse Modulation
Criteria for compliance:	There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

7.3.1 Test Setup and Procedure



1. For table-top equipment, the EUT was placed in the chamber on a non-conductive table 0.8m high. For arrangement of floor-standing equipment, the EUT was mounted on a non-conductive support 0.1m above the supporting plane. For human body-mounted equipment, the EUT may be tested in the same manner as table top items.
2. If possible, a minimum of 1 m of cable is exposed to the electromagnetic field. Excess length of cables interconnecting units of the EUT shall be bundled low-inductively in the approximate center of the cable to form a bundle 30 cm to 40 cm in length.

3. The EUT was initially placed with one face coincident with the calibration plane. The EUT face being illuminated was contained within the UFA (Uniform Field Area).
4. The frequency ranges to be considered were swept with the signal modulated and pausing to adjust the RF signal level or to switch oscillators and antennas as necessary. Here the frequency range was swept incrementally, the step size was not exceed 1% of the preceding frequency value.
5. The dwell time of the amplitude modulated carrier at each frequency was not be less than the time necessary for the EUT to be exercised and to respond, and was not less than 0.5 s.
6. The test normally was performed with the generating antenna facing each side of the EUT.
7. The polarization of the field generated by each antenna necessitates testing each selected side twice, once with the antenna positioned vertically and again with the antenna positioned horizontally.
8. The EUT was performed in a configuration to actual installation conditions, a video camera and/or a audio monitor were used to monitor the performance of the EUT.

7.3.2 Test Results

For EN 55024

Frequency	Level	Modulation	Dwell Time	Test Mode	Antenna Polarization	EUT Face	Result / Observations
80 MHz-1 GHz	3.0 V/m	1 kHz, 80% Amp. Mod, 1 % increment	3s	Running mode	V	Front	A
					H		A
					V	Rear	A
					H		A
					V	Left	A
					H		A
					V	Right	A
					H		A
					V	Top	N/A
					H		N/A
					V	Bottom	N/A
					H		N/A

Remarks:

Front: the front of the EUT faces to transmitting antenna (refer to Radiated Immunity test setup photo)

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

N/A: Not applicable.

The EUT does meet the Radiated Immunity requirements of Standard.

For EN 50130

Frequency	Level	Modulation	Test Mode	Dwell Time	Antenna Polarization	EUT Face	Result / Observations
80 MHz-2.7 GHz	10 V/m	(80%, 1kHz, A.M.)&(0.5s ON 0.5s OFF P.M.)	Running mode	3s	V	Front	Pass
					H		Pass
					V	Rear	Pass
					H		Pass
					V	Left	Pass
					H		Pass
					V	Right	Pass
					H		Pass
					V	Top	N/A
					H		N/A
					V	Bottom	N/A
					H		N/A

Test phenomenon description for the EUT:

1. The EUT working normal, before the conditioning.
2. Monitor the EUT during the conditioning period and detected no any changes in states, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

7.4 Electrical Fast Transients (EFT)

For EN 55024

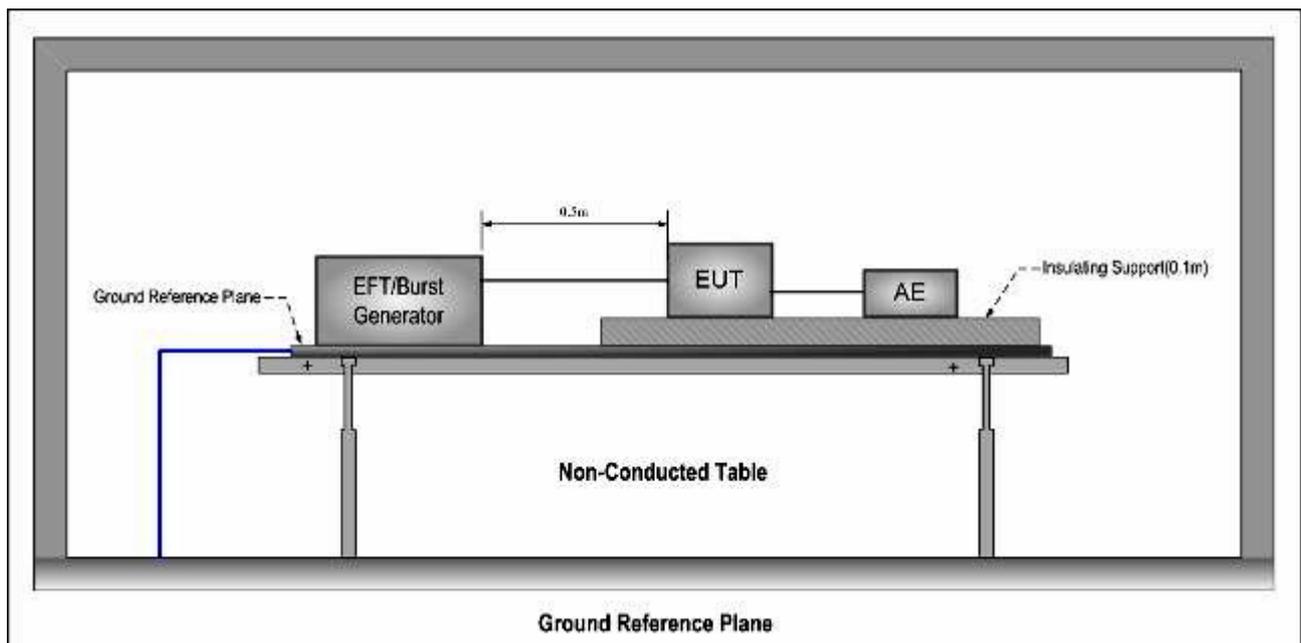
Test Level:	±1.0kV on AC port ±0.5Kv on Signal port
Polarity:	Positive & Negative
Repetition Frequency:	5kHz
Burst Duration:	300ms
Test Duration:	2 minute per level & polarity

For EN 50130

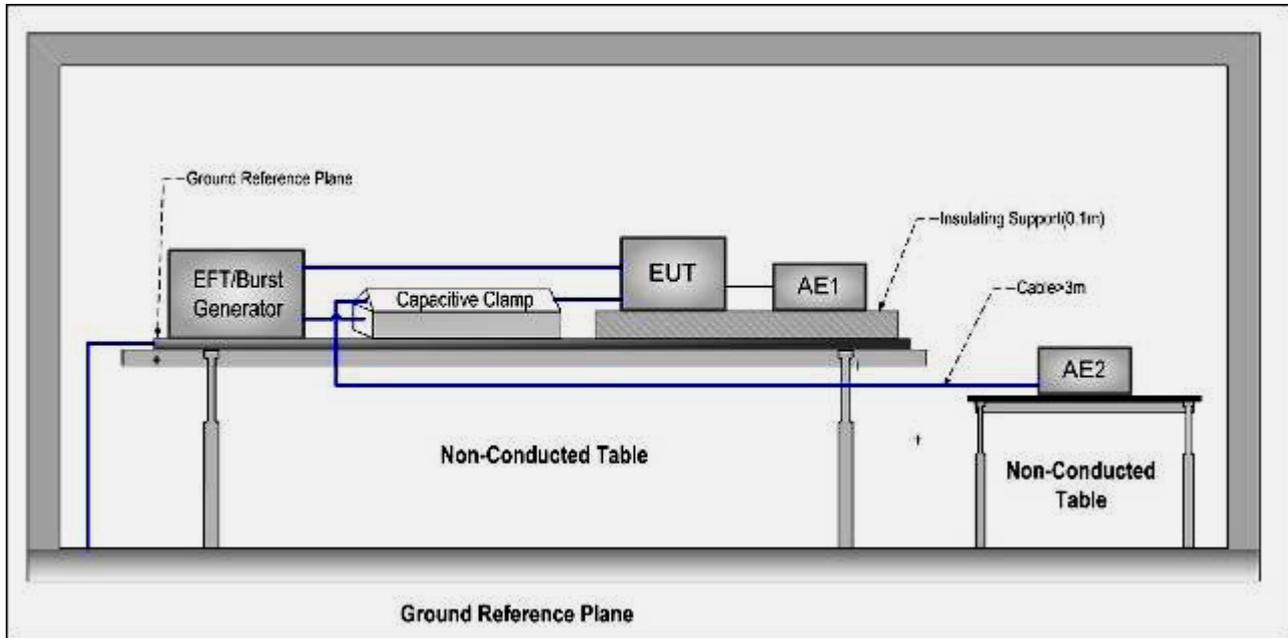
Test Level:	±2.0kV on AC port ±1.0Kv on Signal port
Polarity:	Positive & Negative
Repetition Frequency:	100KHz
Burst Duration:	300ms
Test Duration:	1 minute per level & polarity
Criteria for compliance:	There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

7.4.1 Test Setup and Procedure

For AC port:



For signal port



1. The EUT was placed on a ground reference plane (GRP) insulated by an insulating support 0.1 m thick and the GRP was placed on a 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP.
2. The GRP shall project beyond the EUT and the clamp by at least 0.1m on all sides. The distance between the EUT and any other of the metallic surface except the GRP was greater than 0.5m. All cables to the EUT were placed on the insulation support 0.1m above GRP. Cables not subject to EFT were routed as far as possible from cable under test to minimize the coupling between the cables.
3. The length of signal and power cable between the EUT and EFT generator was 0.5m. If the cable is a non-detachable supply cable more than 0.5m, the excess length of this cable shall be folded to avoid a flat coil and situated at a distance of 0.1m above the GRP.
4. The EUT was conducted the below specified level voltage test for line to neutral or line to neutral to earth (for clamp coupling is for the signal line), 120 seconds duration.
5. If the equipment contains identical ports, only one was tested; multiconductor cables, such as a 50-pair telecommunication cable, were tested as a single cable. Cables did not be split or divided into groups of conductors for this test; interface ports, which were intended by the manufacturer to be connected to data cables not longer than 3 m, did not be tested.

7.4.2 Test Results

For EN 55024

AC port

Lead under Test	Level (±kV)	Coupling Direct/Clamp	Test mode	Observations (Performance Criterion)
Live + Neutral	± 1.0	Direct	Running mode	(A)

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

Signal port

Lead under Test	Level (±kV)	Coupling Direct/Clamp	Test mode	Observations (Performance Criterion)
Signal cable	± 0.5	Clamp	Running mode	(A)

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

For EN 50130

AC port:

Lead under Test	Level (±kV)	Coupling Direct/Clamp	Test mode	Observations (Performance Criterion)
Live + Neutral	±2.0	Direct	Running mode	Pass

Signal port

Lead under Test	Level (±kV)	Coupling Direct/Clamp	Test mode	Observations (Performance Criterion)
Signal cables	± 1.0	Clamp	Running mode	Pass

Test phenomenon description for the EUT:

1. The EUT working normal, before the conditioning.
2. Monitor the EUT during the conditioning period and detected no any changes in states, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

7.5 Slow high energy voltage surge

For EN 55024

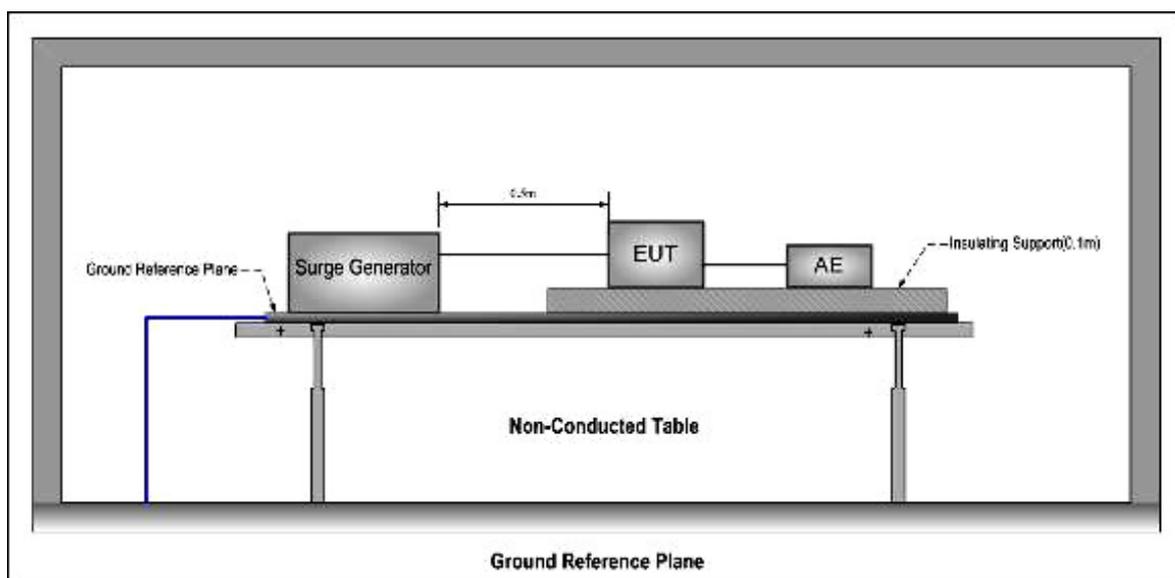
Test Level: $\pm 1.0\text{kV}$ For AC port & Signal port
Polarity: Positive & Negative
Generator source impedance: 2Ω for Line to Neutral
Trigger Mode: Internal
No. of surges: 5 positive, 5 negative at 0° , 90° , 180° , 270°

For EN 50130

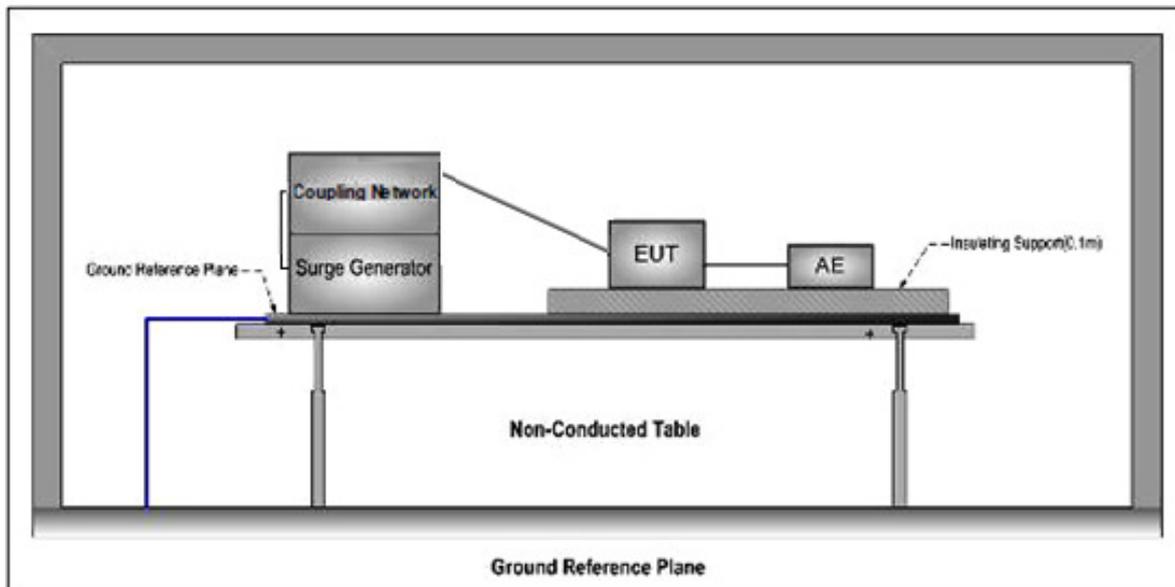
Test Level: For AC port:
 ± 0.5 , $\pm 1.0\text{kV}$ Line to Line
For Signal port:
 ± 0.5 , $\pm 1.0\text{kV}$ Line to Ground
Polarity: Positive & Negative
Generator source impedance: 2Ω on Line to Line
 42Ω on Signal ports
Trigger Mode: Internal
No. of surges: 5 positive, 5 negative at 0° , 90° , 180° , 270°
Criteria for compliance: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the surges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

7.5.1 Test Setup and Procedure

For AC/DC port



For signal port



1. The EUT was placed on a ground reference plane (GRP) insulated by an insulating support 0.1 m thick and the GRP was placed on a 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP.
2. The 1,2/50 μ s surge was to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks were required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave so that the specified wave may be applied on the lines under test.
3. The power cord between the EUT and the coupling/decoupling network was not exceeding 2 m in length. The interconnection line between the EUT and the coupling/decoupling network shall not exceed 2 m in length.
4. The EUT was conducted 0.5kV and 1kV test voltage for live to neutral and line to neutral and conducted 0.5kV, 1kV and 2kV test voltage for line to earth and neutral to earth, five positive pulses and five negative pulses each at 0°, 90°, 180° and 270° for a.c. power ports and five positive pulses and five negative surge pulses for d.c. power ports. The test levels were applied on the EUT with a 2 Ω generator source impedance for power supply terminals and 40 Ω output impedance for interconnection lines. The tests were done at repetition rate one per minute.

7.5.2 Test Results:

For EN 55024

AC port

Pulse No	Line-Line	Level (kV)	Surge Interval	Phase (deg)	Test Mode	Observation (Performance Criterion)
1-5	L-N	+ 1.0	60 s	0°	Running mode	(A)
6-10	L-N	- 1.0	60 s	0°		(A)
11-15	L-N	+ 1.0	60 s	90°		(A)
16-20	L-N	- 1.0	60 s	90°		(A)
21-25	L-N	+ 1.0	60 s	180°		(A)
26-30	L-N	- 1.0	60 s	180°		(A)
31-35	L-N	+ 1.0	60 s	270°		(A)
36-40	L-N	- 1.0	60 s	270°		(A)

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

Signal port

Pulse No	Line under test	Matching resistor	Level (kV)	Surge Interval	Test Mode	Observation (Performance Criterion)
1-5	Line-Ground	42 ohm	+1.0	60s	Running mode	(A)
6-10	Line-Ground	42 ohm	-1.0	60s		(A)

A: No degradation in the performance of the E.U.T. was observed.

The EUT does meet the Surge immunity on telecommunication requirements of Standard.

For EN 50130

AC port:

Pulse No	Line-Line	Level (kV)	Surge Interval	Phase (deg)	Test Mode	Observation (Performance Criterion)
1-10	L-N	+0.5, 1.0	60 s	0°	Running mode	Pass
11-20	L-N	-0.5, 1.0	60 s	0°		Pass
21-30	L-N	+0.5, 1.0	60 s	90°		Pass
31-40	L-N	-0.5, 1.0	60 s	90°		Pass
41-50	L-N	+0.5, 1.0	60 s	180°		Pass
51-60	L-N	-0.5, 1.0	60 s	180°		Pass
61-70	L-N	+0.5, 1.0	60 s	270°		Pass
71-80	L-N	-0.5, 1.0	60 s	270°		Pass

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

Signal port

Pulse No	Line under test	Matching resistor	Level (kV)	Surge Interval	Test Mode	Observation (Performance Criterion)
1-5	Line-Ground	42 ohm	-0.5, 1.0	60s	Running mode	Pass
6-10	Line-Ground	42 ohm	+0.5, 1.0	60s		Pass

Test phenomenon description for the EUT:

1. The EUT working is normal, before the conditioning.
2. Monitor the specimen during the conditioning period to detect no any change in status, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

7.6 Conducted disturbances induced by electromagnetic fields

For EN 55024

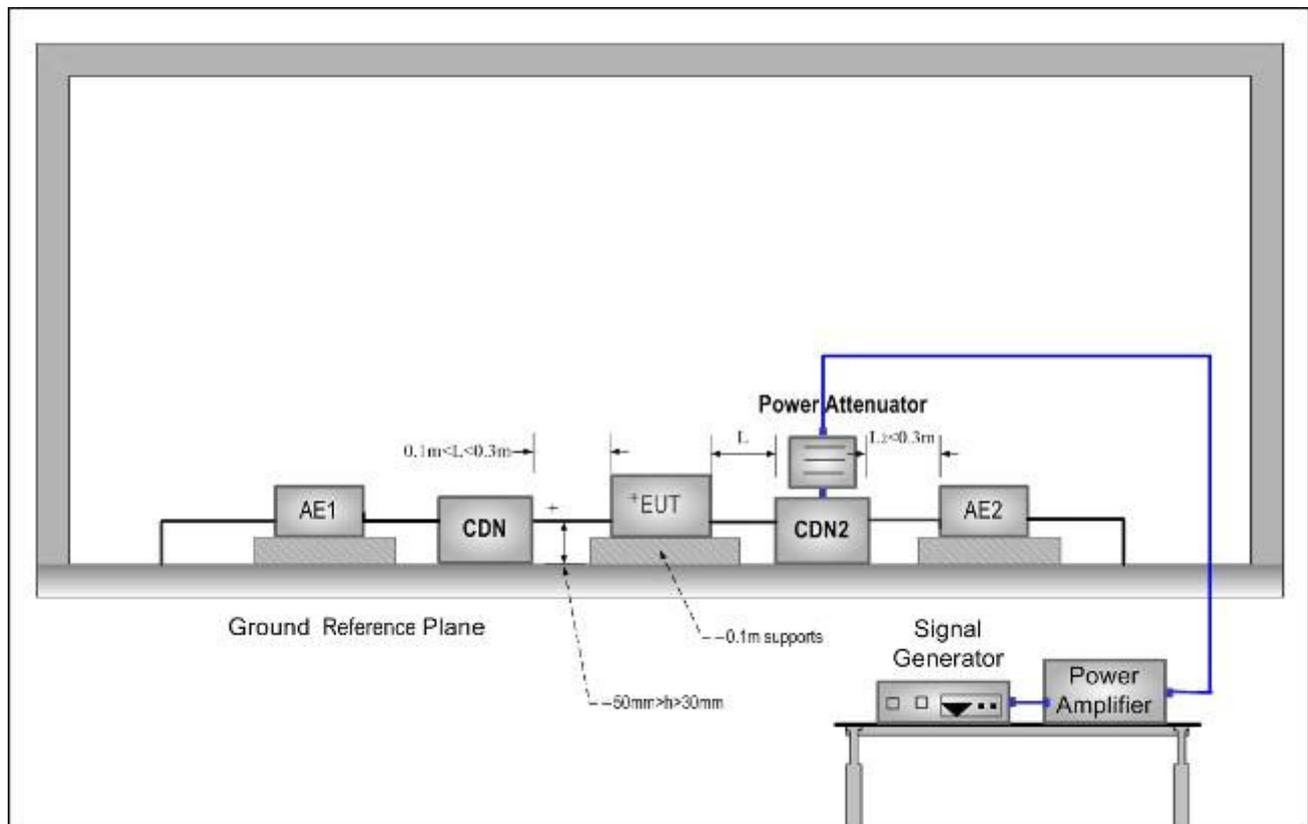
Frequency Range:	0.15 MHz to 80 MHz
Test level:	3.0V r.m.s on AC Ports (unmodulated emf into 150 Ω) & 3.0V r.m.s on signal Ports (unmodulated emf into 150 Ω)
Modulation:	80%, 1kHz Amplitude Modulation

For EN 50130

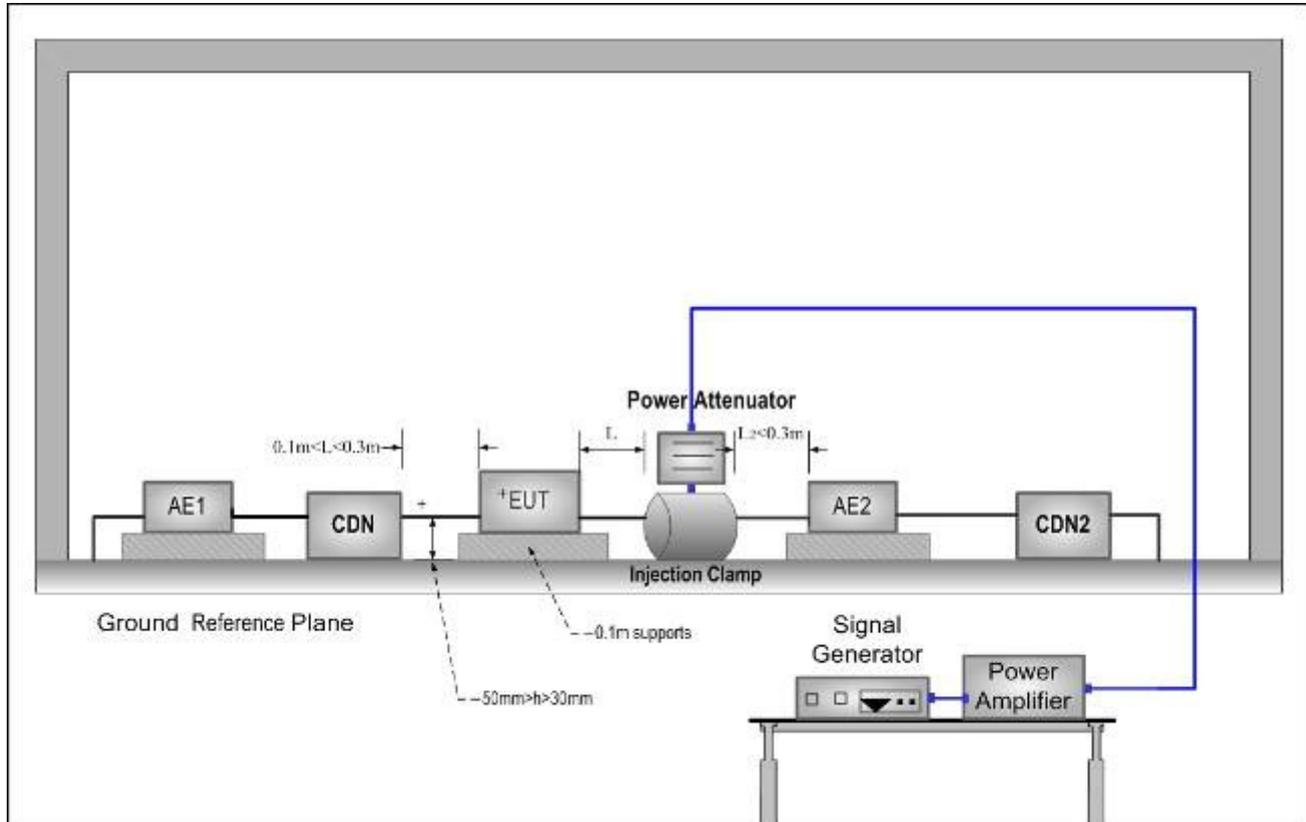
Frequency Range:	0.15 MHz to 100 MHz
Test level:	10V r.m.s (unmodulated emf into 150 Ω)
Modulation:	80%, 1kHz Amplitude Modulation & 0.5s ON 0.5s OFF Pulse Modulation
Criteria for compliance:	There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at $U_0 = 130$ dBuV.

7.6.1 Test Setup and Procedure

For AC port



For Signal port



1. The EUT was placed on an insulating support of 0.1 m height above a ground reference Plane, arranged and connected to satisfy its functional requirement. All cables exiting the EUT was supported at a height of at least 30 mm above the ground reference plane.
2. The coupling and decoupling devices were required, they were located between 0,1 m and 0,3 m from the EUT. This distance was to be measured horizontally from the projection of the EUT on to the ground reference plane to the coupling and decoupling device.
3. Each AE, used with clamp injection, shall be placed on an insulating support 0,1 m above the ground reference plane. A decoupling network shall be installed on each cable between the EUT and AE except the cable under test. All cables connected to each AE, other than those being connected to the EUT, shall be provided with decoupling networks. The decoupling networks connected to each AE (except those on cables between the EUT and AE) shall be applied no further than 0,3 m from the AE. The cable(s) between the AE and the decoupling network (s) or in between the AE and the injection clamp shall not be bundled nor wrapped and shall be kept between 30 mm and 50 mm above the ground reference plane.
4. The frequency range was swept from 150 kHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or to change coupling devices as necessary. Where the frequency was swept incrementally, the step size do not exceed 1% of the preceding frequency value. The dwell time of the amplitude modulated carrier at each frequency was not less than the time necessary for the EUT to be exercised and to respond, and was not less than 0.5 s.
5. If the interface ports, which were intended by the manufacturer to be connected to data cables not longer than 3 m, did not be tested.

7.6.2 Test Results

For EN 55024

AC Port:

Frequency	Line	Test Level	Modulation	Step Size	Dwell Time	Test Mode	Observation (Performance Criterion)
150 kHz to 80 MHz	2 Wires Supply Cable	3.0V r.m.s	80%, 1 kHz Amp. Mod.	1%	3s	Running mode	No Loss of Function (A)

Signal Port:

Frequency	Line	Test Level	Modulation	Step Size	Dwell Time	Test Mode	Observation (Performance Criterion)
150 kHz to 80 MHz	Signal Cable	3.0V r.m.s	80%, 1 kHz Amp. Mod.	1%	3s	Running mode	No Loss of Function (A)

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

For EN 50130

Frequency	Line	Test Level	Modulation	Step Size	Dwell Time	Test Mode	Test Results
150kHz to 100MHz	AC Mains	10Vr.m.s	80%, 1kHz Amp. Mod.	1%	3s	Running mode	Pass
150kHz to 100MHz	AC Mains	10Vr.m.s	0.5s ON, 0.5s OFF P.M. Mod.	1%	3s		Pass
150kHz to 100MHz	Signal ports	10Vr.m.s	80%, 1kHz Amp. Mod.	1%	3s		Pass
150kHz to 100MHz	Signal ports	10Vr.m.s	0.5s ON, 0.5s OFF P.M. Mod.	1%	3s		Pass

Test phenomenon description for the EUT:

1. The EUT working is normal, before the conditioning.
2. Monitor the specimen during the conditioning period to detect in status some flickering for signal cables(such as Video input & Video output cables, Audio input & Audio output cables) test, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

7.7 Mains supply voltage dips and short interruptions

For EN 55024

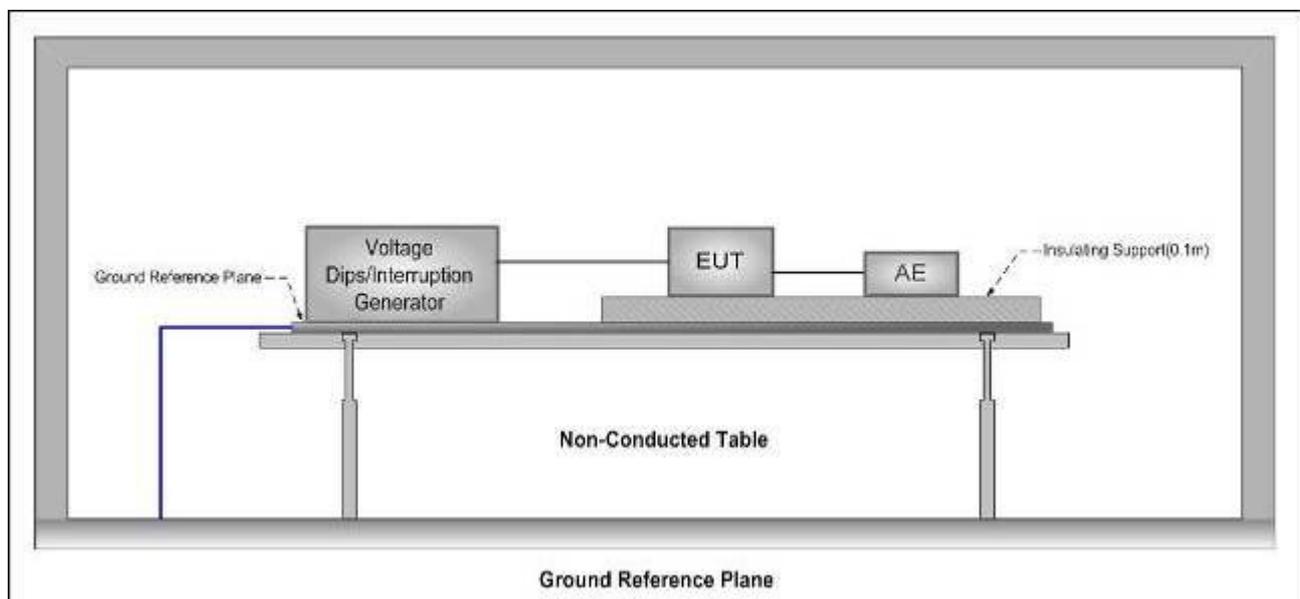
Test voltage:	Refer to U_T
Test Level:	0% of U_T (Supply Voltage) for 0.5 Periods 0% of U_T (Supply Voltage) for 250 Periods 70 % of U_T (Supply Voltage) for 25 Periods
No. of Dips / Interruptions:	3 per Level

For EN 50130

Voltage dips and short interruptions:	0 % U_T for 250 period 40 % U_T for 10 period 70 % U_T for 25 period 80 % U_T for 250 period (U_T is the nominal supply voltage.)
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Criteria:	There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.
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7.7.1 Test Setup and Procedure



1. The EUT was placed on a ground reference plane (GRP) insulated by an insulating support 0,1 m thick and the GRP was placed on a 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP.
2. The test was performed with the EUT connected to the test generator with the shortest power supply cable as specified by the EUT manufacturer.
3. The EUT was tested for each selected combination of test level and duration with a sequence of three dips /interruptions with intervals of 10 s minimum. Each representative mode of operation was tested.
4. For EUT with more than one power cord, each power cord was tested individually.

7.7.2 Test Results

For EN 55024

$U_{T=}$ AC 230V 50Hz

Test Level % U_T	Phase	Duration of drop out in Periods	No of drop out	Time between drop out	Test Mode	OBSERVATIONS (PERFORMANCE CRITERION)
0	0°,180°	0.5	3	10s	Running mode	(A)
0	0°,180°	250	3	10s		(A)
70	0°,180°	25	3	10s		(A)

Remark:

$U_{T=}$ the nominal supply voltage.

A: During test, no degradation in the performance of the EUT was observed; After test, no degradation in the performance of the EUT was observed.

The EUT does meet the Voltage Dips and Interruptions requirements of Standard.

For EN 50130

$U_{T=}$ AC 230V 50Hz

Test Level % U_T	Phase	Duration of drop out in Periods	No. of drop out	Time between drop out	Test Mode	Test Results
0	0°,180°	250	3	10s	Running mode	Pass
40	0°,180°	10	3	10s		Pass
70	0°,180°	25	3	10s		Pass
80	0°,180°	250	3	10s		Pass

Remark:

According to the client's requirement, we used a UPS as ancillary equipment to meet the requirements of this clause during test.

$U_{T=}$ the nominal supply voltage.

Test phenomenon description for the EUT:

1. The EUT working normal, before the conditioning.
2. Monitor the EUT during the conditioning period and detected no any changes in states, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

7.8 Mains supply voltage variations

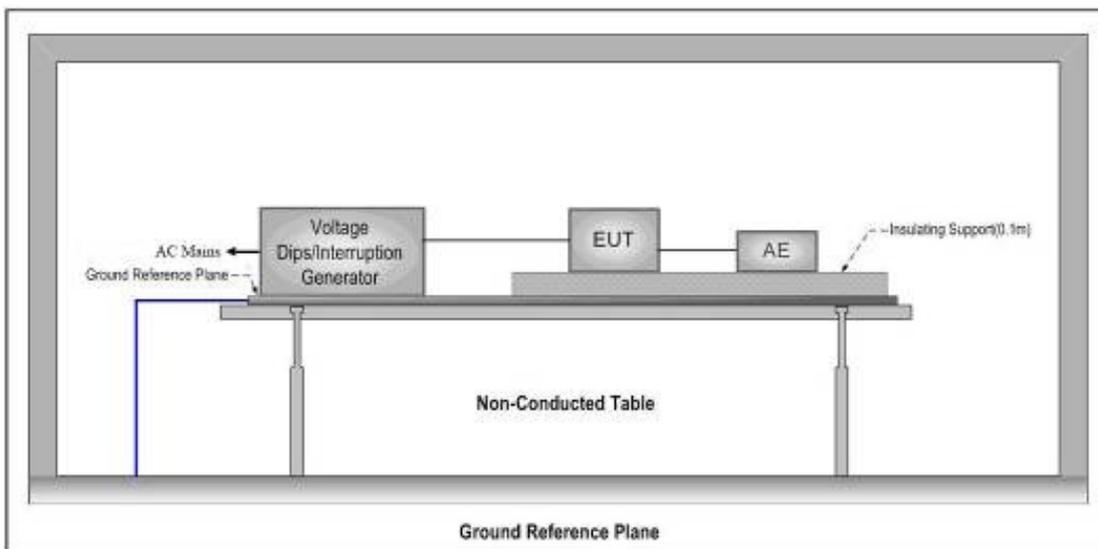
Voltage max.	AC 253V ($U_{max}: U_{nom} + 10\%$)
Voltage min.	AC 195.5V ($U_{min}: U_{nom} - 15\%$)
Unom Voltage:	AC 230V
Criteria:	There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test (see Clause 6 of EN 50130-4), during the conditioning.

7.8.1 Test Results:Pass

Test phenomenon description for the EUT:

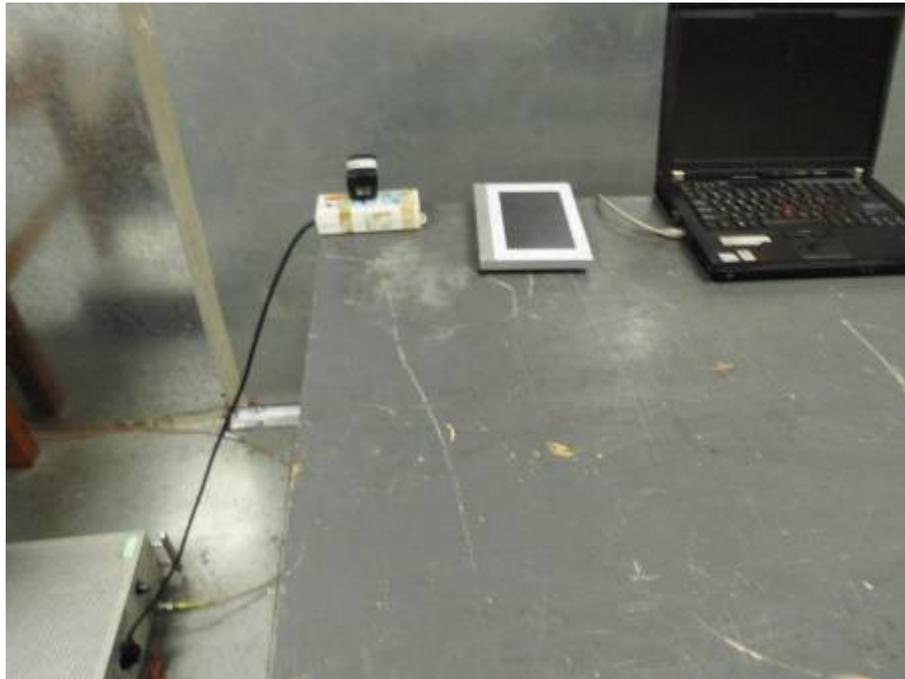
1. The EUT working normal, before the conditioning.
2. Monitor the EUT during the conditioning period and detected no any changes in states, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

Test Setup:

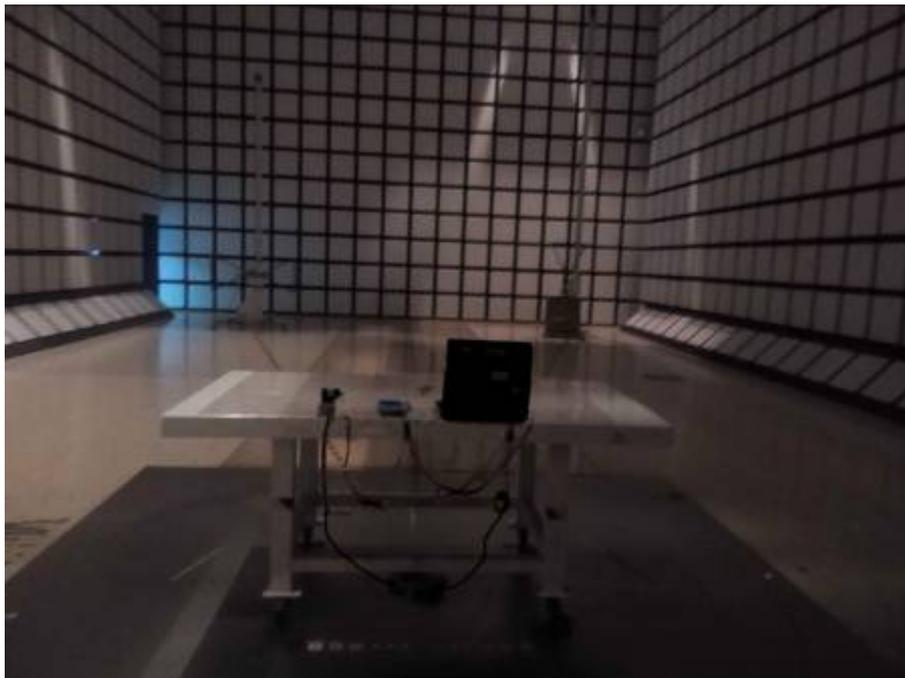


8 Photographs (Test Setup For the EUT)

8.1 Conducted Emissions on Mains Terminals Test Setup



8.2 Radiated Emission Test Setup



8.3 Flicker Test Setup



8.4 ESD Test Setup



8.5 Radiated Immunity Test Setup



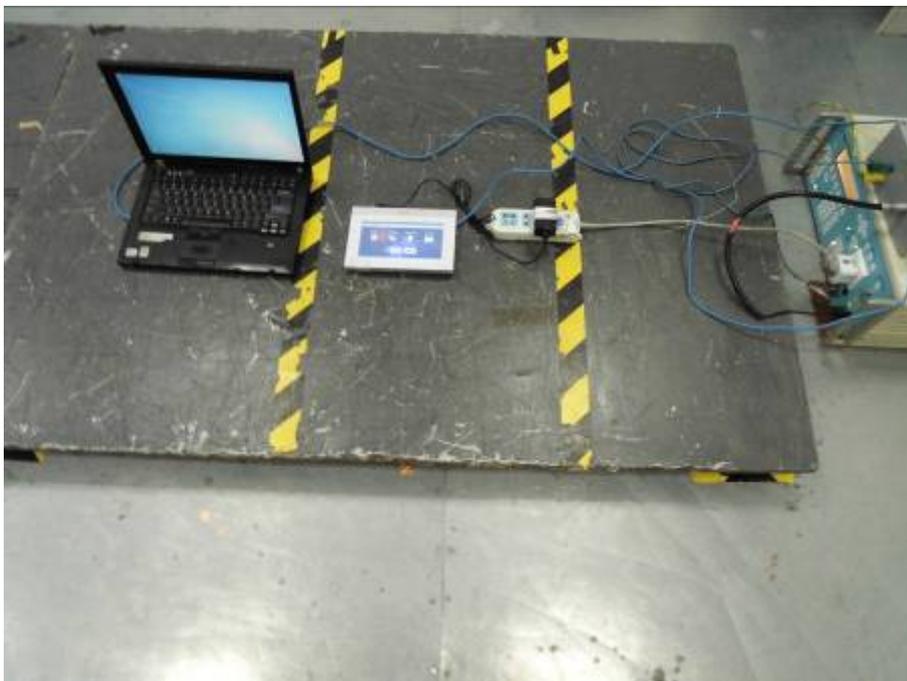
8.6 EFT, Surge, Voltage Dip and Interruptions on Mains Terminals Test Setup



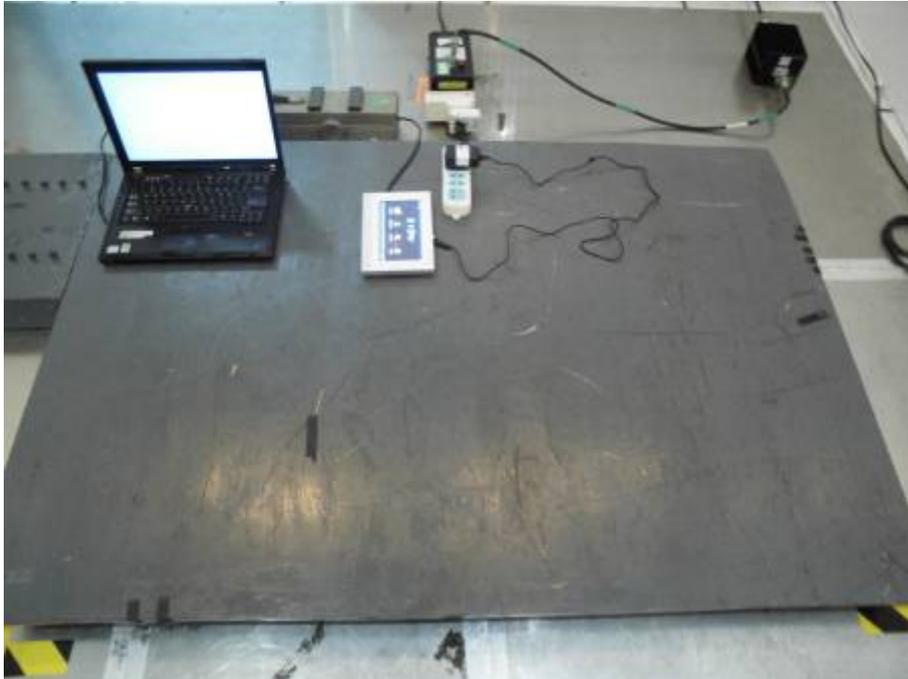
8.7 EFT on signal Terminals Test Setup



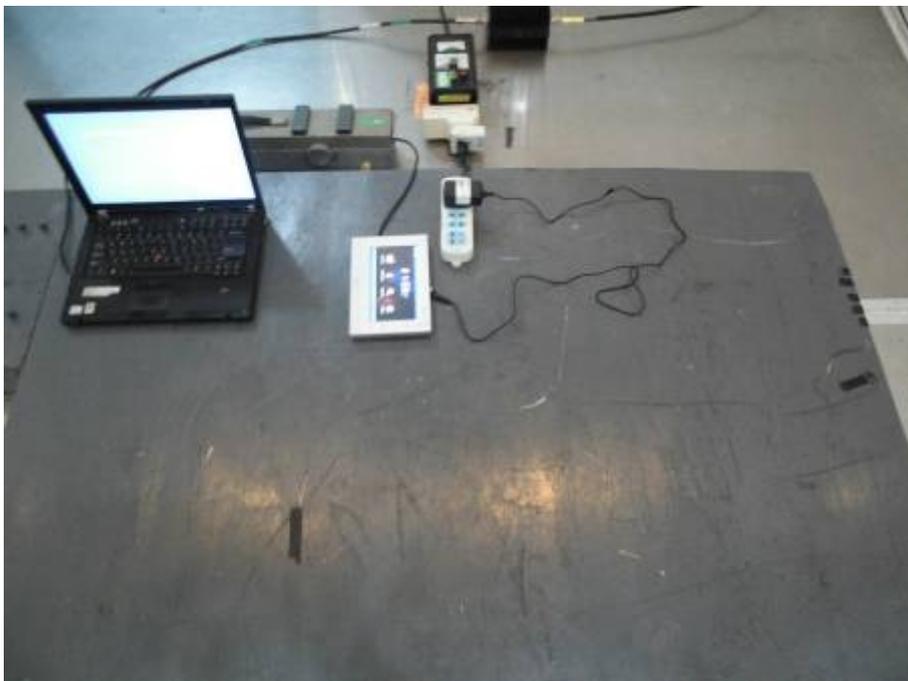
8.8 Surge on signal Terminals Test Setup



8.9 Conducted Immunity on Mains Terminals Test Setup



8.10 Conducted Immunity on signal Terminals Test Setup



9 EUT Constructional Details

9.1 Exterior of EUT



9.2 Interior of EUT



--End of the Report--